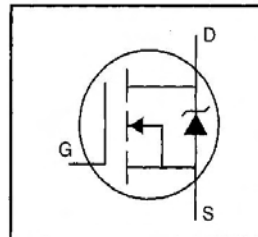


# IRF530SPbF

## HEXFET® Power MOSFET

- Surface Mount
- Available in Tape & Reel
- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- 175°C Operating Temperature
- Fast Switching
- Ease of Paralleling
- Lead-Free

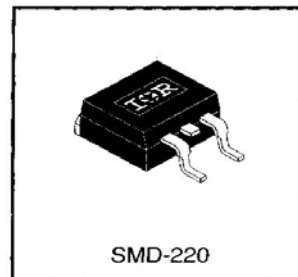


|                           |
|---------------------------|
| $V_{DSS} = 100V$          |
| $R_{DS(on)} = 0.16\Omega$ |
| $I_D = 14A$               |

### Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SMD-220 is a surface mount power package capable of accommodating die sizes up to HEX-4. It provides the highest power capability and the lowest possible on-resistance in any existing surface mount package. The SMD-220 is suitable for high current applications because of its low internal connection resistance and can dissipate up to 2.0W in a typical surface mount application.



### Absolute Maximum Ratings

|                           | Parameter                                 | Max.                  | Units |
|---------------------------|---|-----------------------|-------|
| $I_D @ T_C = 25^\circ C$  | Continuous Drain Current, $V_{GS} @ 10 V$ | 14                    | A     |
| $I_D @ T_C = 100^\circ C$ | Continuous Drain Current, $V_{GS} @ 10 V$ | 10                    |       |
| $I_{DM}$                  | Pulsed Drain Current ①                    | 56                    | W     |
| $P_D @ T_C = 25^\circ C$  | Power Dissipation                         | 88                    |       |
| $P_D @ T_A = 25^\circ C$  | Power Dissipation (PCB Mount)**           | 3.7                   | W/°C  |
|                           | Linear Derating Factor                    | 0.59                  |       |
|                           | Linear Derating Factor (PCB Mount)**      | 0.025                 |       |
| $V_{GS}$                  | Gate-to-Source Voltage                    | $\pm 20$              | V     |
| $E_{AS}$                  | Single Pulse Avalanche Energy ②           | 69                    | mJ    |
| $I_{AR}$                  | Avalanche Current ①                       | 14                    | A     |
| $E_{AR}$                  | Repetitive Avalanche Energy ①             | 8.8                   | mJ    |
| dv/dt                     | Peak Diode Recovery dv/dt ③               | 5.5                   | V/ns  |
| $T_J, T_{STG}$            | Junction and Storage Temperature Range    | -55 to +175           | °C    |
|                           | Soldering Temperature, for 10 seconds     | 300 (1.6mm from case) |       |

### Thermal Resistance

|                 | Parameter                         | Min. | Typ. | Max. | Units |
|-----------------|-----------------------------------|------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case                  | —    | —    | 1.7  | °C/W  |
| $R_{\theta JA}$ | Junction-to-Ambient (PCB mount)** | —    | —    | 40   |       |
| $R_{\theta JA}$ | Junction-to-Ambient               | —    | —    | 62   |       |

\*\* When mounted on 1" square PCB (FR-4 or G-10 Material).

For recommended footprint and soldering techniques refer to application note #AN-994.

# IRF530SPbF

International  
 Rectifier

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

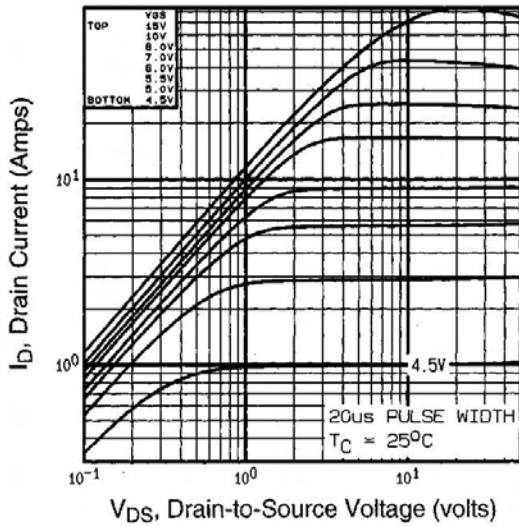
|                                 | Parameter                            | Min. | Typ. | Max. | Units               | Test Conditions   |
|---------------------------------|--------------------------------------|------|------|------|---------------------|---|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 100  | —    | —    | V                   | $V_{GS}=0V, I_D=250\mu A$   |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.12 | —    | V/ $^\circ\text{C}$ | Reference to $25^\circ\text{C}$ , $I_D=1\text{mA}$                  |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | —    | 0.16 | $\Omega$            | $V_{GS}=10V, I_D=8.4A$ ④  |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 2.0  | —    | 4.0  | V                   | $V_{DS}=V_{GS}, I_D=250\mu A$                                       |
| $g_{fs}$                        | Forward Transconductance             | 5.1  | —    | —    | S                   | $V_{DS}=50V, I_D=8.4A$ ④  |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —    | 25   | $\mu A$             | $V_{DS}=100V, V_{GS}=0V$  |
|                                 |                                      | —    | —    | 250  |                     | $V_{DS}=80V, V_{GS}=0V, T_J=150^\circ\text{C}$                      |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —    | 100  | nA                  | $V_{GS}=20V$  |
|                                 | Gate-to-Source Reverse Leakage       | —    | —    | -100 |                     | $V_{GS}=-20V$   |
| $Q_g$                           | Total Gate Charge                    | —    | —    | 26   | nC                  | $I_D=14A$   |
| $Q_{gs}$                        | Gate-to-Source Charge                | —    | —    | 5.5  |                     | $V_{DS}=80V$  |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | —    | —    | 11   |                     | $V_{GS}=10V$ See Fig. 6 and 13 ④                                    |
| $t_{d(on)}$                     | Turn-On Delay Time                   | —    | 10   | —    | ns                  | $V_{DD}=50V$  |
| $t_r$                           | Rise Time                            | —    | 34   | —    |                     | $I_D=14A$   |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | —    | 23   | —    |                     | $R_G=12\Omega$  |
| $t_f$                           | Fall Time                            | —    | 24   | —    |                     | $R_D=3.6\Omega$ See Figure 10 ④                                     |
| $L_D$                           | Internal Drain Inductance            | —    | 4.5  | —    | nH                  | Between lead, 6 mm (0.25in.) from package and center of die contact |
| $L_S$                           | Internal Source Inductance           | —    | 7.5  | —    |                     |   |
| $C_{iss}$                       | Input Capacitance                    | —    | 670  | —    | pF                  | $V_{GS}=0V$   |
| $C_{oss}$                       | Output Capacitance                   | —    | 250  | —    |                     | $V_{DS}=25V$  |
| $C_{rss}$                       | Reverse Transfer Capacitance         | —    | 60   | —    |                     | $f=1.0\text{MHz}$ See Figure 5                                      |

## Source-Drain Ratings and Characteristics

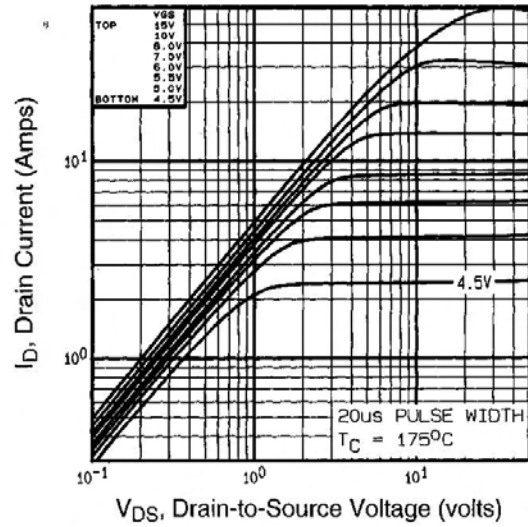
|          | Parameter                              | Min.  | Typ. | Max. | Units   | Test Conditions  |
|----------|--|---|------|------|---------|--|
| $I_S$    | Continuous Source Current (Body Diode) | —   | —    | 14   | A       | MOSFET symbol showing the integral reverse p-n junction diode. |
| $I_{SM}$ | Pulsed Source Current (Body Diode) ①   | —   | —    | 56   |         |  |
| $V_{SD}$ | Diode Forward Voltage                  | —   | —    | 2.5  | V       | $T_J=25^\circ\text{C}, I_S=14A, V_{GS}=0V$ ④                   |
| $t_{rr}$ | Reverse Recovery Time                  | —   | 150  | 280  | ns      | $T_J=25^\circ\text{C}, I_F=14A$                                |
| $Q_{rr}$ | Reverse Recovery Charge                | —   | 0.85 | 1.7  | $\mu C$ | $di/dt=100A/\mu s$ ④   |
| $t_{on}$ | Forward Turn-On Time                   | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ ) |      |      |         |  |

### Notes:

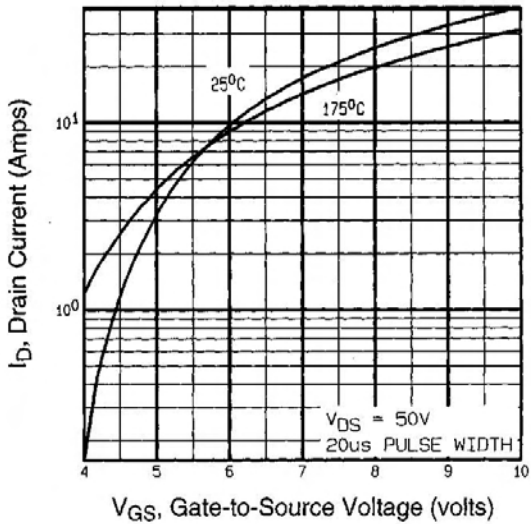
- ① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)
- ②  $V_{DD}=25V$ , starting  $T_J=25^\circ\text{C}$ ,  $L=528\mu H$ ,  $R_G=25\Omega$ ,  $I_{AS}=14A$  (See Figure 12)
- ③  $I_{SD}\leq 14A$ ,  $di/dt\leq 140A/\mu s$ ,  $V_{DD}\leq V_{(BR)DSS}$ ,  $T_J\leq 175^\circ\text{C}$
- ④ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$ .



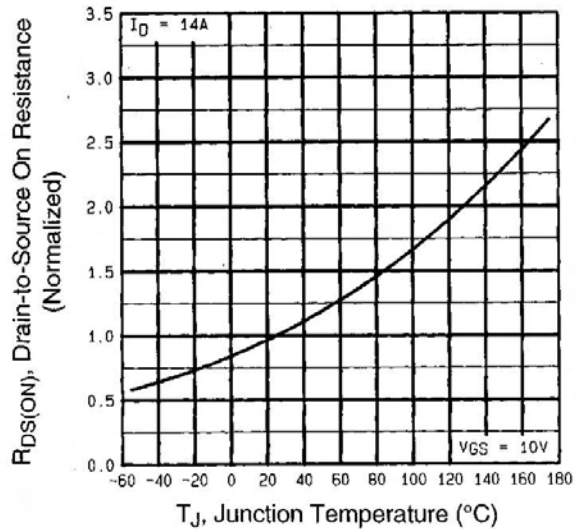
**Fig 1.** Typical Output Characteristics,  
 $T_C=25^\circ\text{C}$



**Fig 2.** Typical Output Characteristics,  
 $T_C=175^\circ\text{C}$



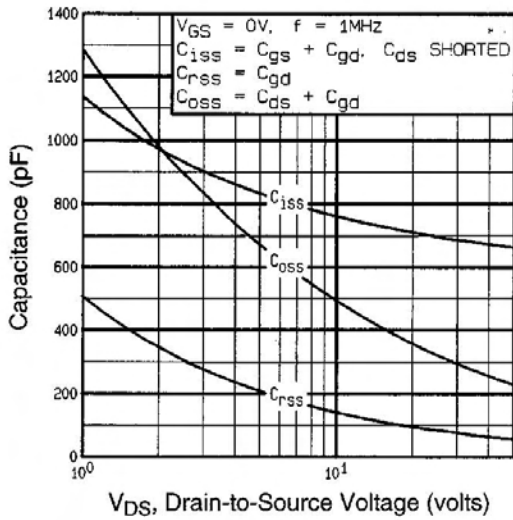
**Fig 3.** Typical Transfer Characteristics



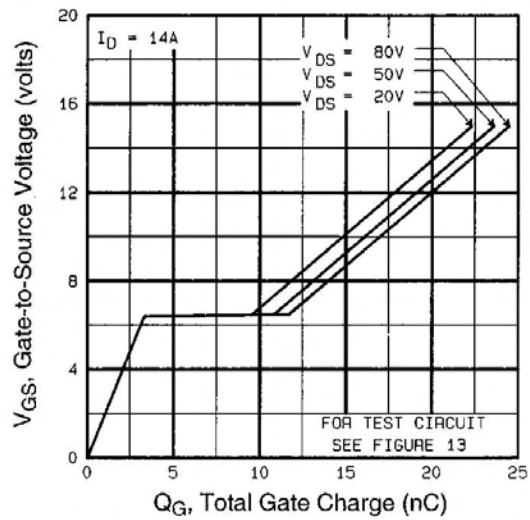
**Fig 4.** Normalized On-Resistance  
 Vs. Temperature

# IRF530SPbF

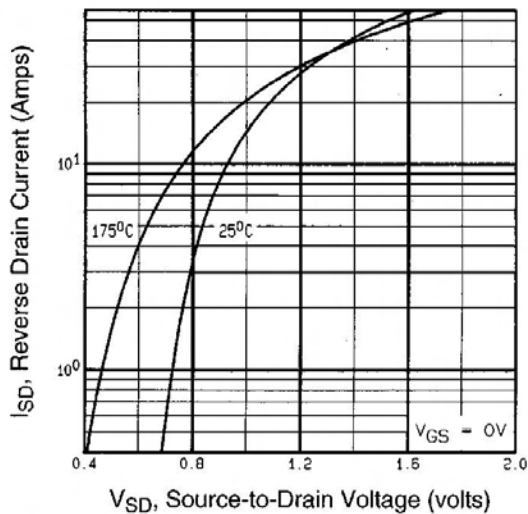
International  
**IR** Rectifier



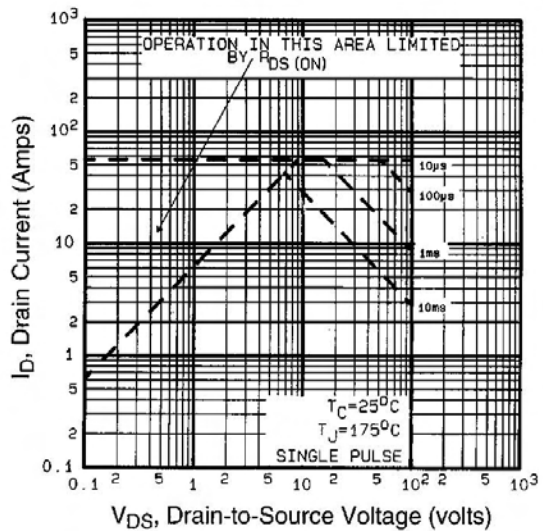
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage

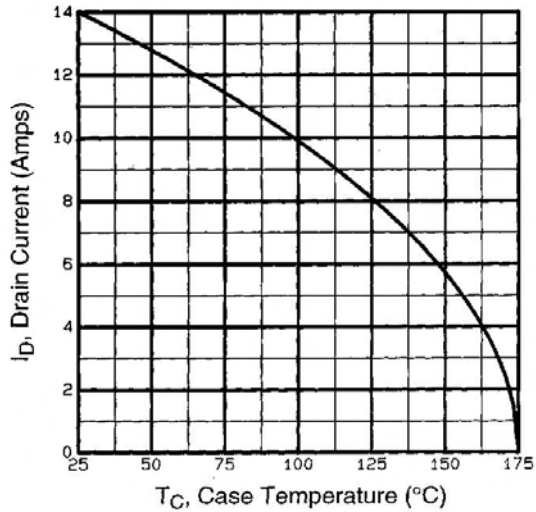


**Fig 7.** Typical Source-Drain Diode Forward Voltage

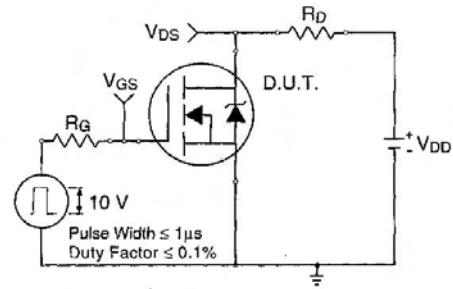


**Fig 8.** Maximum Safe Operating Area

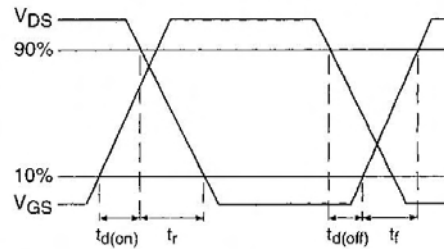




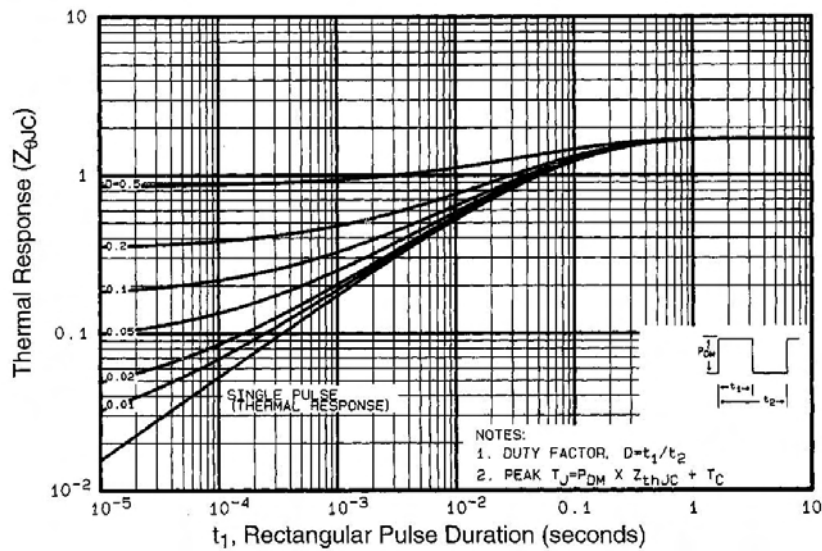
**Fig 9.** Maximum Drain Current Vs. Case Temperature



**Fig 10a.** Switching Time Test Circuit

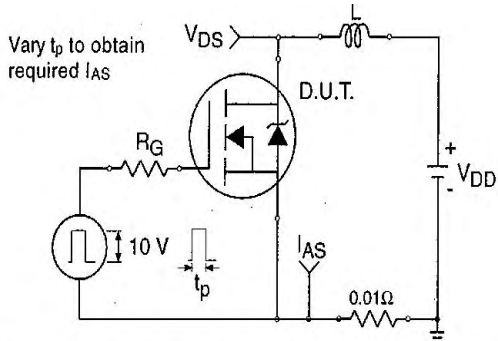


**Fig 10b.** Switching Time Waveforms

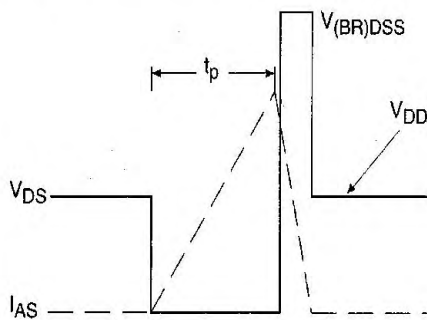


**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

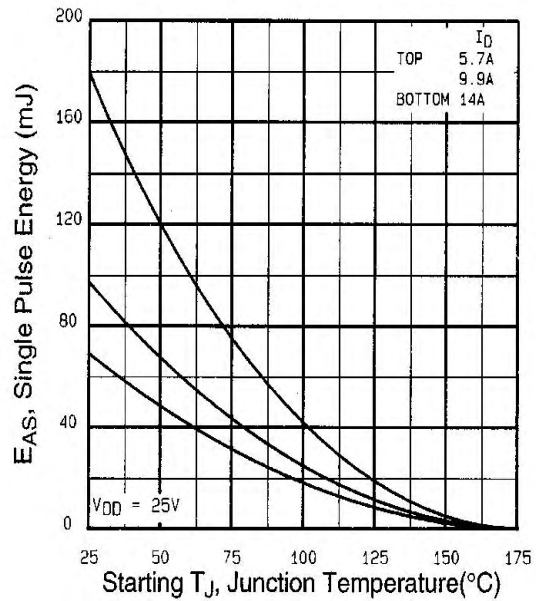
# IRF530SPbF



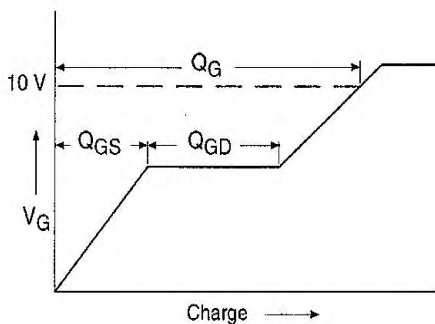
**Fig 12a.** Unclamped Inductive Test Circuit



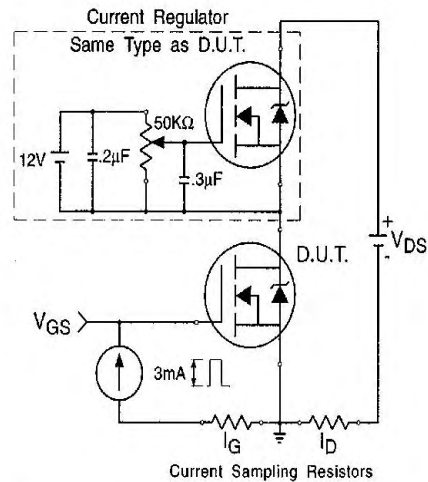
**Fig 12b.** Unclamped Inductive Waveforms



**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current

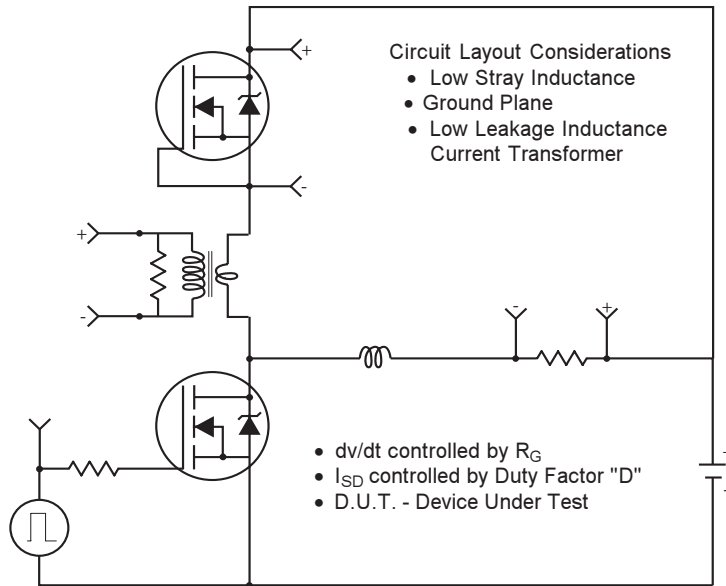


**Fig 13a.** Basic Gate Charge Waveform



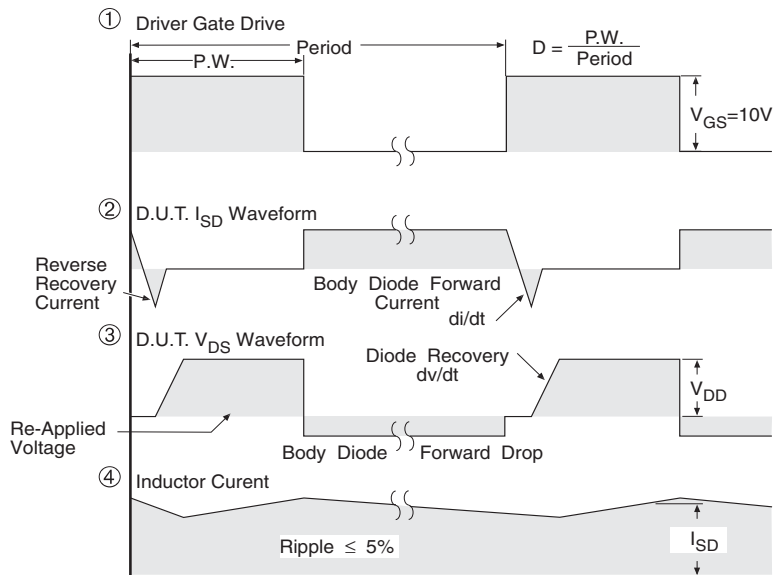
**Fig 13b.** Gate Charge Test Circuit

## Peak Diode Recovery dv/dt Test Circuit



\* Reverse Polarity for P-Channel

\*\* Use P-Channel Driver for P-Channel Measurements



\*\*\*  $V_{GS} = 5.0V$  for Logic Level and 3V Drive Devices

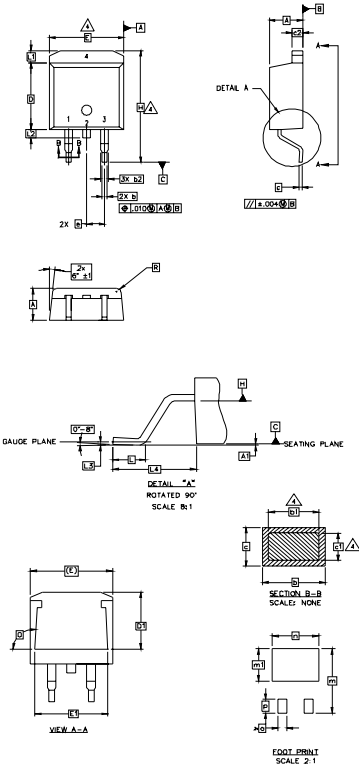
**Fig 14** For N Channel HEXFETS

# IRF530SPbF

## D<sup>2</sup>Pak Package Outline

International  
**IR** Rectifier

Dimensions are shown in millimeters (inches)



**NOTES:**

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [ .005" ] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
4. DIMENSION b1 AND c1 APPLY TO BASE METAL ONLY.
5. CONTROLLING DIMENSION: INCH.

| SYMBOL | DIMENSIONS  |       |          |      | NOTES |
|--------|-------------|-------|----------|------|-------|
|        | MILLIMETERS |       | INCHES   |      |       |
|        | MIN.        | MAX.  | MIN.     | MAX. |       |
| A      | 4.06        | 4.83  | .160     | .190 |       |
| A1     | 0.00        | 0.254 | .000     | .010 |       |
| b      | 0.51        | 0.99  | .020     | .039 |       |
| b1     | 0.51        | 0.89  | .020     | .035 | 4     |
| b2     | 1.14        | 1.78  | .045     | .070 |       |
| c      | 0.38        | 0.74  | .015     | .029 |       |
| c1     | 0.38        | 0.58  | .015     | .023 | 4     |
| c2     | 1.14        | 1.65  | .045     | .065 |       |
| D      | 8.51        | 9.65  | .335     | .380 | 3     |
| D1     | 6.86        |       | .270     |      |       |
| E      | 9.65        | 10.67 | .380     | .420 | 3     |
| E1     | 6.22        |       | .245     |      |       |
| e      | 2.54 BSC    |       | .100 BSC |      |       |
| H      | 14.61       | 15.88 | .575     | .625 |       |
| L      | 1.78        | 2.79  | .070     | .110 |       |
| L1     |             | 1.65  |          | .065 |       |
| L2     | 1.27        | 1.78  | .050     | .070 |       |
| L3     | 0.25 BSC    |       | .010 BSC |      |       |
| L4     | 4.78        | 5.28  | .188     | .208 |       |
| m      | 17.78       |       | .700     |      |       |
| m1     | 8.89        |       | .350     |      |       |
| n      | 11.43       |       | .450     |      |       |
| o      | 2.08        |       | .082     |      |       |
| p      | 3.81        |       | .150     |      |       |
| R      | 0.51        | 0.71  | .020     | .028 |       |
| θ      | 90°         | 93°   | 90°      | 93°  |       |

LEAD ASSIGNMENTS

HEXFET

- 1.- GATE
- 2, 4.- DRAIN
- 3.- SOURCE

IGBTs, CoPACK

- 1.- GATE
- 2, 4.- COLLECTOR
- 3.- EMITTER

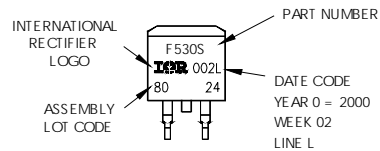
DIODES

- 1.- ANODE \*
- 2, 4.- CATHODE
- 3.- ANODE

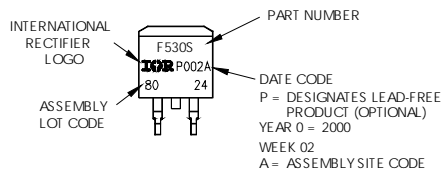
\* PART DEPENDENT.

## D<sup>2</sup>Pak Part Marking Information

EXAMPLE: THIS IS AN IRF530S WITH  
LOT CODE 8024  
ASSEMBLED ON WW 02, 2000  
IN THE ASSEMBLY LINE "L"  
  
Note: "P" in assembly line  
position indicates "Lead-Free"



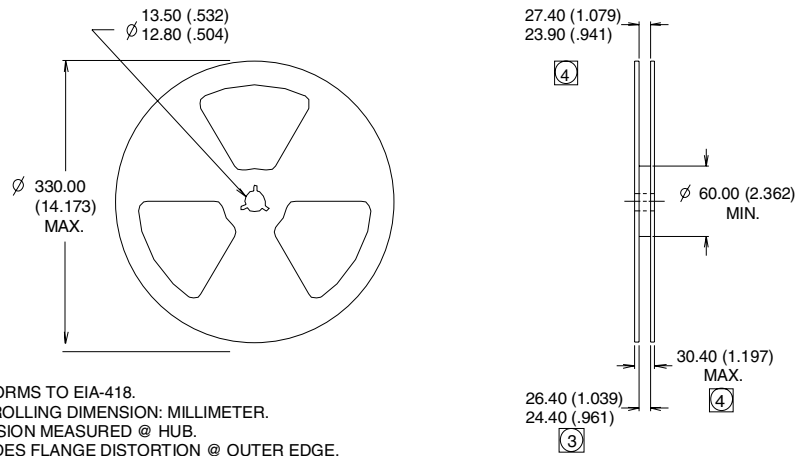
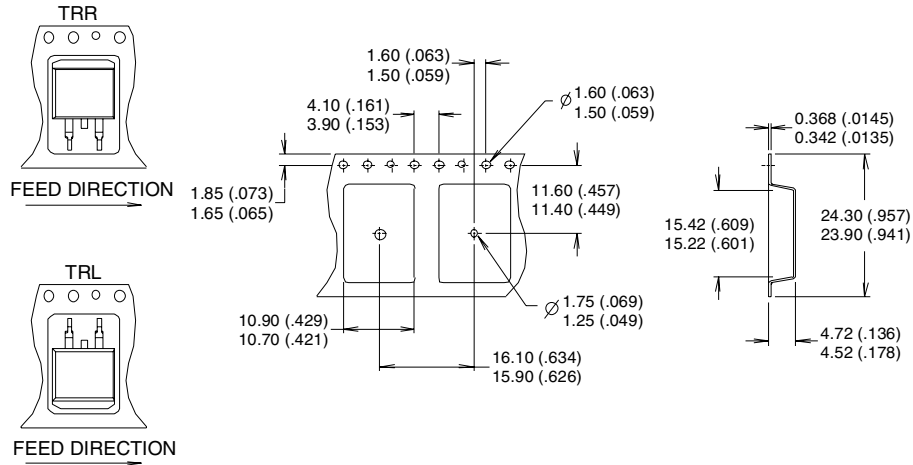
OR





## D<sup>2</sup>Pak Tape & Reel Information

Dimensions are shown in millimeters (inches)



- NOTES:
1. CONFORMS TO EIA-418.
  2. CONTROLLING DIMENSION: MILLIMETER.
  - ③ DIMENSION MEASURED @ HUB.
  - ④ INCLUDES FLANGE DISTORTION @ OUTER EDGE.

Data and specifications subject to change without notice.



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